Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSIII)

2SK2968

DC-DC Converter, Relay Drive and Motor Drive Applications

• Low drain-source ON resistance $: RDS (ON) = 1.05 \Omega (typ.)$

• High forward transfer admittance $: |Y_{fs}| = 7.6 \text{ S (typ.)}$

 $\begin{array}{l} \bullet \quad \text{Low leakage current} \quad : I_{DSS} = 100 \; \mu\text{A (max)} \; (V_{DS} = 720 \; \text{V}) \\ \bullet \quad \text{Enhancement-mode} \quad : V_{th} = 2.0 \text{\sim} 4.0 \; \text{V (V}_{DS} = 10 \; \text{V, I}_{D} = 1 \; \text{mA}) \end{array}$

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	900	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	900	V	
Gate-source voltage		V_{GSS}	±30	V	
Drain current	DC (Note 1)	I _D	10	Α	
	Pulse (Note 1)	I _{DP}	30	Α	
Drain power dissipation	n (Tc = 25°C)	P_{D}	150	W	
Single pulse avalanche energy (Note 2)		E _{AS}	810	mJ	
Avalanche current		I _{AR}	10	Α	
Repetitive avalanche energy (Note 3)		E _{AR}	15	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature ra	ange	T _{stg}	-55~150	°C	

Weight: 4.6 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	0.833	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	50	°C/W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

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Note 2: V_{DD} = 90 V, T_{ch} = 25°C (initial), L = 14.9 mH, R_G = 25 Ω , I_{AR} = 10 A

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device.

Please handle with caution.

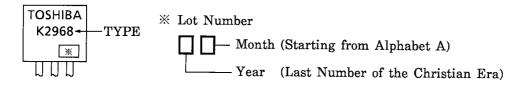
Electrical Characteristics (Ta = 25°C)

Charac	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	rrent	I _{GSS}	V _{GS} = ±30 V, V _{DS} = 0 V	_	_	±10	μΑ
Gate-source bre	eakdown voltage	V (BR) GSS	I _G = ±10 μA, V _{DS} = 0 V	±30	_	_	V
Drain cut-off cur	rent	I _{DSS}	V _{DS} = 720 V, V _{GS} = 0 V	_	_	100	μΑ
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	900	_	_	V
Gate threshold v	roltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source Ol	N resistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 4 A	_	1.05	1.25	Ω
Forward transfer	admittance	Y _{fs}	V _{DS} = 15 V, I _D = 4 A	3.5	7.6	_	S
Input capacitano	е	C _{iss}		_	2150	_	
Reverse transfer	capacitance	C _{rss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz	_	35	_	pF
Output capacitar	nce	C _{oss}		_	220	_	
Switching time	Rise time	t _r	V_{GS} V_{OUT} V_{OUT} V_{DD} V_{OUT} V_{DD}	_	25	_	ns
	Turn-on time	t _{on}		_	60	_	
	Fall time	t _f		_	25	_	
	Turn-off time	t _{off}	Duty $\leq 1\%$, $t_{\mathbf{W}} = 10 \mu s$	_	120	_	
Total gate charge (gate-source plus gate-drain)		Qg		_	70		_
Gate-source charge		Q _{gs}	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		37	_	nC
Gate-drain ("miller") Charge		Q_{gd}		_	33	_	

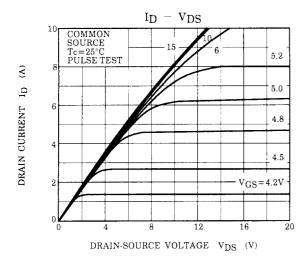
Source-Drain Ratings and Characteristics (Ta = 25°C)

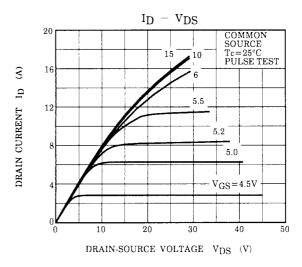
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	10	Α
Pulse drain reverse current (Note 1)	I _{DRP}	-	_	_	30	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = 10 A, V _{GS} = 0 V	_	_	-1.9	V
Reverse recovery time	t _{rr}	I _{DR} = 10 A, V _{GS} = 0 V dI _{DR} / dt = 100 A / μs		1300	_	ns
Reverse recovery charge	Q _{rr}		_	14.5	_	μC

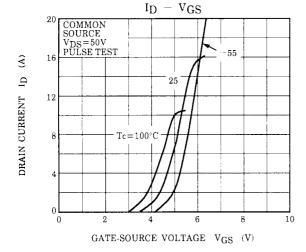
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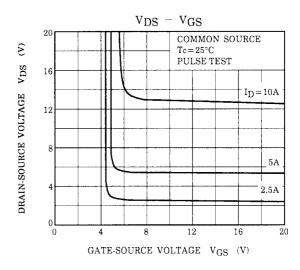


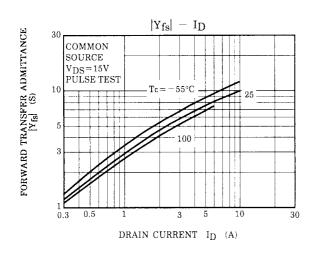
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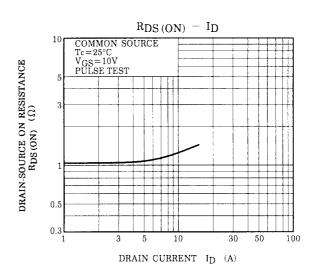


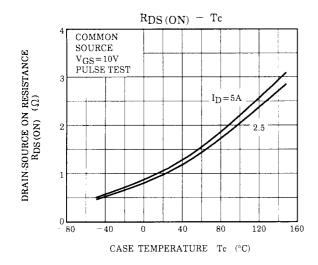


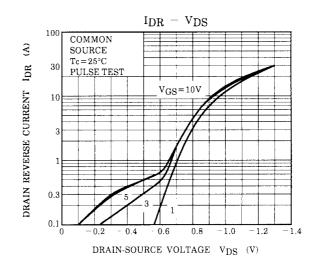


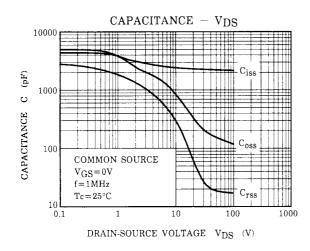


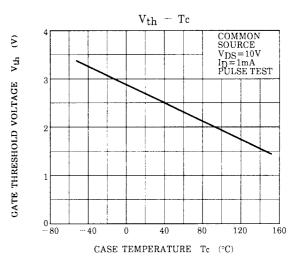


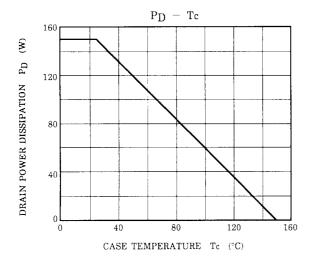


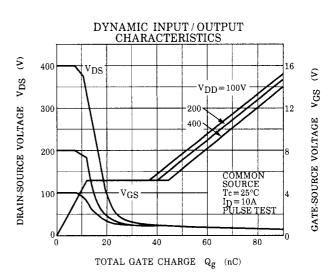




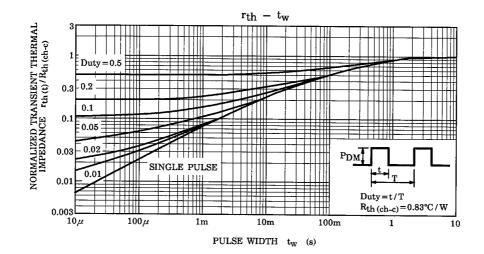


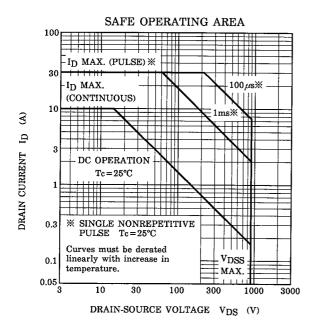


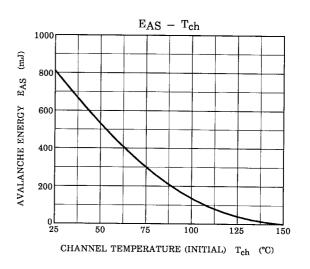


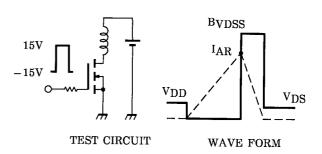


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$$R_G$$
 = 25 Ω
 V_{DD} = 90 V, L = 14.9 mH

$$E_{AS} = \frac{1}{2} \cdot L \cdot I^{2} \cdot \left(\frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$$

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